

Search Notes

Application/Control No.

10/619,044

Examiner

C. SAYALA

Applicant(s)/Patent under
Reexamination

MEYER ET AL.

Art Unit

1794

SEARCHED

| Class | Subclass | Date | Examiner |
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| 426 | 1 | 1/2/2008 | CS |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| search updated | 1/2/2008 | CS |
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